

Substitute for form 1449A/PTO

**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

(use as many sheets as necessary)

Sheet 1 of 1

Complete if Known

Application Number	Unknown
Filing Date	April 7, 2004
First Named Inventor	Francesco CRETTI
Art Unit	Unknown
Examiner Name	Unknown
Attorney Docket Number	2110-110-3

U.S. PATENT DOCUMENTS

Examiner Initials *	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number - Kind Code ² (if known)			
	AA	US- 5,057,838	10/15/91	Kazuhiro Tsuji et al.	
	AB	US- 6,118,398	09/12/00	Gregory J. Fisher et al.	
	AC	US- 6,426,715 B1	07/30/02	Jan Roelof Westra et al.	
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FOREIGN PATENT DOCUMENTS

Examiner Initials *	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
		Country Code ³ - Number ⁴ - Kind Code ⁵ (if known)				

OTHER PRIOR ART -- NON PATENT LITERATURE DOCUMENTS

Examiner Initials *	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
	AD	GEERT A.M. VAN DER PLAS, et al.; "A 14-bit Intrinsic Accuracy Q ² Random Walk CMOS DAC"; IEEE Journal of Solid-State Circuits; December 1999; pgs. 1708-1718; Vol. 34, no. 12; IEEE; New York
	AE	YONGHUA CONG et al.; "Switching Sequence Optimization for Gradient Error Compensation in Thermometer-Decoded DAC Arrays"; IEEE Transaction on Circuits and Systems - II: Analog and digital Signal Processing; July 2000; pgs. 585-595; Vol. 47, no. 7; IEEE; New York
	AF	European Search Report dated September 24, 2003

Examiner Signature	Date Considered
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. 1 Applicant's unique citation designation number (optional). 2 See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. 3 Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). 4 For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. 5 Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. 6 Applicant is to place a check mark here if English language Translation is attached.

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